Enhanced ultrafast rectifier diode

Rev. 01 — 30 June 2009

Product data sheet

1. Product profile

1.1 General description

Enhanced ultrafast epitaxial rectifier diode in a SOD113 (2-lead TO-220F) plastic package.

1.2 Features and benefits

- High thermal cycling performance
- Isolated package
- Low on-state losses

1.3 Applications

Dual Mode (DCM and CCM) PFC

- Low thermal resistance
- Soft recovery characteristic
- Power factor Correction (PFC) for Interleaved Topology

1.4 Quick reference data

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{RRM}	repetitive peak reverse voltage		-	-	600	V
I _{F(AV)}	average forward current	square-wave pulse; $\delta = 0.5$; T _h = 72 °C; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	9	A
Dynamic	characteristics					
t _{rr}	reverse recovery time	I _F = 1 A; V _R = 30 V; dI _F /dt = 100 A/μs; T _j = 25 °C; see <u>Figure 5</u>	-	17.5	35	ns
Static ch	aracteristics					
V _F	forward voltage	I _F = 9 A; T _j = 150 °C; see <u>Figure 4</u>	-	1.3	1.9	V



2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	К	cathode		
2	А	anode	mb	K — A 001aaa020
mb	n.c.	mounting base; isolated		
			SOD113	

3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BYV29FX-600	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 2-lead TO-220 "full pack"	SOD113			

(TO-220F)

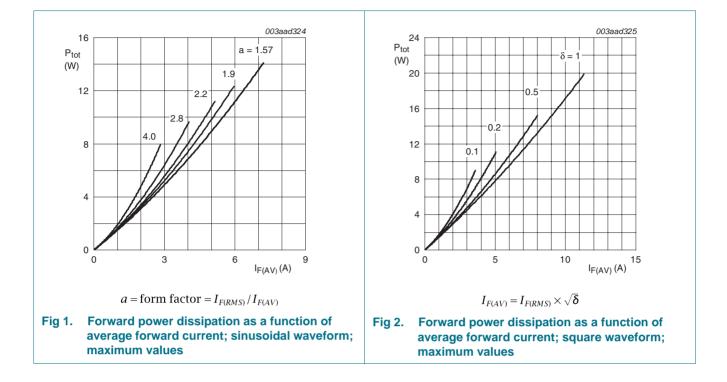
4. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

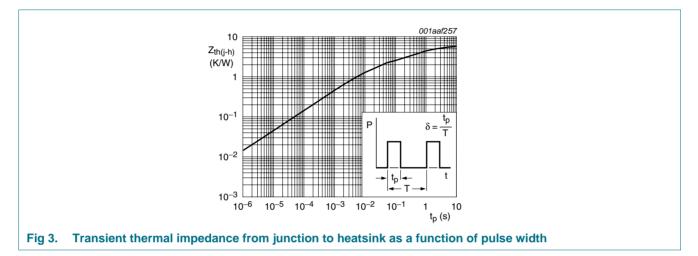
Symbol	Parameter	Conditions	Min	Мах	Unit
V _{RRM}	repetitive peak reverse voltage		-	600	V
V _{RWM}	crest working reverse voltage		-	600	V
V _R	reverse voltage	DC	-	600	V
I _{F(AV)}	average forward current	square-wave pulse; δ = 0.5; T _h = 72 °C; see Figure 1; see Figure 2	-	9	A
I _{FRM}	repetitive peak forward current	square-wave pulse; δ = 0.5; t_p = 25 $\mu s;$ T_h = 72 °C	-	18	A
I _{FSM}	non-repetitive peak	$t_p = 10 \text{ ms}$; sine-wave pulse; $T_{j(init)} = 25 \text{ °C}$	-	91	А
	forward current	t _p = 8.3 ms; sine-wave pulse; T _{j(init)} = 25 °C	-	100	А

Enhanced ultrafast rectifier diode



5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-h)}	thermal resistance from junction to heatsink	with heatsink compound; see Figure 3	-	-	5.5	K/W
R _{th(j-a)}	thermal resistance from junction to ambient free air		-	55	-	K/W

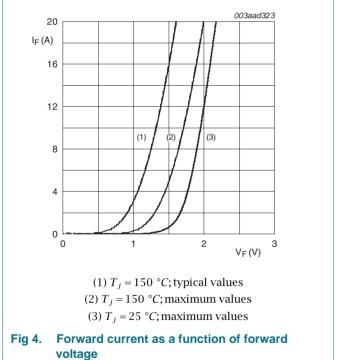


6. Isolation characteristics

Table 6.	Isolation characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{isol}(\text{RMS})}$	RMS isolation voltage	f = 1 MHz; $RH = 65 %$; between all pins and external heatsink	-	-	2500	V
C _{isol}	isolation capacitance	from cathode to external heatsink; $f = 1 \text{ MHz}$	-	10	-	pF

7. Characteristics

Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _F	forward voltage	I _F = 9 A; T _j = 25 °C; see <u>Figure 4</u>	-	1.4	2.1	V
		I _F = 9 A; T _j = 150 °C; see <u>Figure 4</u>	-	1.3	1.9	V
I _R	reverse current	V _R = 600 V; T _j = 150 °C	-	-	1.5	mA
		$V_{R} = 600 \text{ V}; \text{ T}_{j} = 25 \text{ °C}$	-	-	50	μA
Dynamic	characteristics					
Qr	recovered charge	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A}/\mu\text{s}$; see <u>Figure 5</u>	-	13	-	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A}/\mu\text{s}$; $T_j = 25 ^\circ\text{C}$; see <u>Figure 5</u>	-	17.5	35	ns
I _{RM}	peak reverse recovery current	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A}/\mu\text{s}$; see <u>Figure 5</u>	-	1.5	-	А
V_{FR}	forward recovery voltage	$I_F = 1 \text{ A}; \text{ d}I_F/\text{d}t = 100 \text{ A}/\mu\text{s}; \text{ see } \frac{\text{Figure 6}}{100 \text{ A}}$	-	3.2	-	V



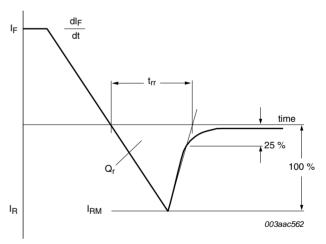
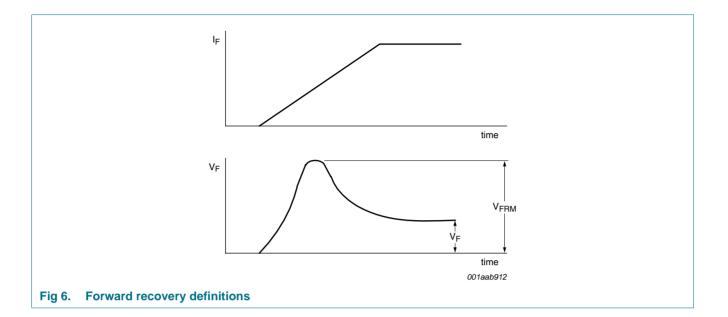


Fig 5. Reverse recovery definitions; ramp recovery

Enhanced ultrafast rectifier diode



Package outline 8.

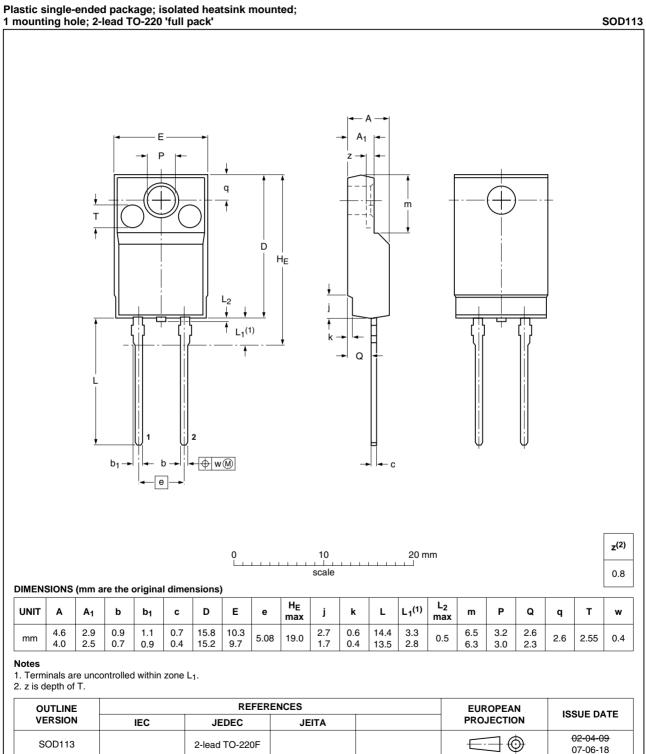


Fig 7. Package outline SOD113 (TO-220F)

9. Revision history

Table 8. Revision h	Revision history						
Document ID	Release date	Data sheet status	Change notice	Supersedes			
BYV29FX-600_1	20090630	Product data sheet	-	-			

10. Legal information

10.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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12. Contents

1	Product profile1
1.1	General description1
1.2	Features and benefits1
1.3	Applications1
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values2
5	Thermal characteristics4
6	Isolation characteristics4
7	Characteristics5
8	Package outline7
9	Revision history8
10	Legal information9
10.1	Data sheet status9
10.2	Definitions9
10.3	Disclaimers
10.4	Trademarks9
11	Contact information

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Date of release: 30 June 2009 Document identifier: BYV29FX-600_1